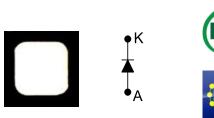
#### **Die Datasheet** GB50SLT12-CAL **GeneSiC Silicon Carbide Power** 1200 V V<sub>RRM</sub> = **Schottky Diode** I<sub>F</sub> @ 25 °C 100 A = $\mathbf{Q}_{\mathsf{C}}$ 158 nC = Features • 1200 V Schottky rectifier

- 175 °C maximum operating temperature
- Temperature independent switching behavior
- Superior surge current capability
- Positive temperature coefficient of V<sub>F</sub>
- Extremely fast switching speeds
- Superior figure of merit Q<sub>C</sub>/I<sub>F</sub>

### **Advantages**

- Improved circuit efficiency (Lower overall cost)
- · Low switching losses
- · Ease of paralleling devices without thermal runaway
- · Smaller heat sink requirements
- · Low reverse recovery current
- Low device capacitance
- Low reverse leakage current at operating temperature



Die Size = 4.5 mm x 4.5 mm

### Applications

- Automotive Traction Inverters
- Power Factor Correction (PFC)
- Switched-Mode Power Supply (SMPS)
- Solar Inverters
- Wind Turbine Inverters
- Motor Drives
- Induction Heating
- Uninterruptible Power Supply (UPS)

### Maximum Ratings at T<sub>i</sub> = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit	
Repetitive peak reverse voltage	V <sub>RRM</sub>		1200	V	
Continuous forward current	l <sub>F</sub>	$T_{C} = 25 \ ^{\circ}C, R_{thJC} = 0.24$	100	А	
Continuous forward current	I <sub>F</sub>	$T_{C} \le 135 \text{ °C}, R_{thJC} = 0.24$	50	А	
RMS forward current	I <sub>F(RMS)</sub>	$T_{C} \le 135 \text{ °C}, R_{thJC} = 0.24$	87	А	
Surge non-repetitive forward current, Half Sine	I <sub>F,SM</sub>	$T_{C} = 25 \text{ °C}, t_{P} = 10 \text{ ms}$	350	А	
Wave		$T_{\rm C}$ = 135 °C, $t_{\rm P}$ = 10 ms	313		
Non-repetitive peak forward current	I <sub>F,max</sub>	$T_{C} = 25 \text{ °C}, t_{P} = 10 \ \mu s$	1625	А	
l <sup>2</sup> t value	∫i² dt	$T_{C} = 25 \text{ °C}, t_{P} = 10 \text{ ms}$	450	A <sup>2</sup> s	
		T <sub>C</sub> = 135 °C, t <sub>P</sub> = 10 ms	300		
Power dissipation	P <sub>tot</sub>	$T_{C} = 25 \ ^{\circ}C, R_{thJC} = 0.24$	620	W	
Operating and storage temperature	T <sub>i</sub> , T <sub>stg</sub>		-55 to 175	°C	

### Electrical Characteristics at T<sub>j</sub> = 175 °C, unless otherwise specified

Parameter	Symphol	Conditions —		Values		Unit	
	Symbol			min.	typ.	max.	Unit
Diode forward voltage	VF	I <sub>F</sub> = 50 A, T <sub>j</sub> = 25 °C		1.5	1.8	V	
	VF	I <sub>F</sub> = 50 A, T <sub>j</sub> = 175 °C		2.4	3.0	v	
Reverse current	1	V <sub>R</sub> = 1200 V, T <sub>j</sub> = 25 °C		25	1000	μA	
	I <sub>R</sub>	V <sub>R</sub> = 1200 V, T <sub>j</sub> = 175 °C		100	3000		
Total capacitive charge	0	I <sub>F</sub> ≤ I <sub>F,MAX</sub> dI <sub>F</sub> /dt = 200 A/µs	V <sub>R</sub> = 400 V		158 247		nC
	Qc		$V_{R} = 960 V$				
Switching time		T <sub>i</sub> = 175 °C	$V_{R} = 400 V$		50	20	
	ts		V <sub>R</sub> = 960 V				ns
Total capacitance		V <sub>R</sub> = 1 V, f = 1 MHz, T <sub>j</sub> = 25 °C		2940			
	С	V <sub>R</sub> = 400 V, f = 1 MHz, T <sub>j</sub> = 25 °C		203		pF	
		V <sub>R</sub> = 1000 V, f = 1 MHz, T <sub>j</sub> = 25 °C		142			



# GB50SLT12-CAL

### Figures:

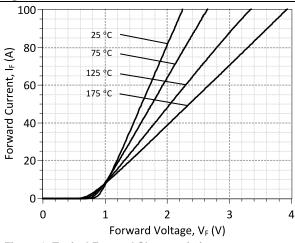


Figure 1: Typical Forward Characteristics

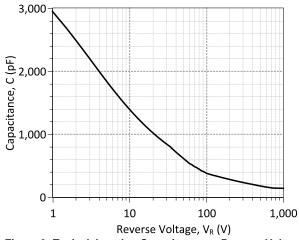


Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

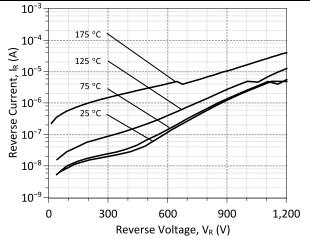


Figure 2: Typical Reverse Characteristics

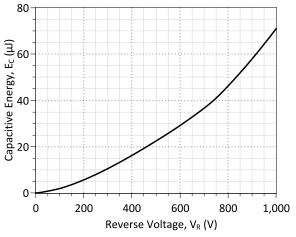


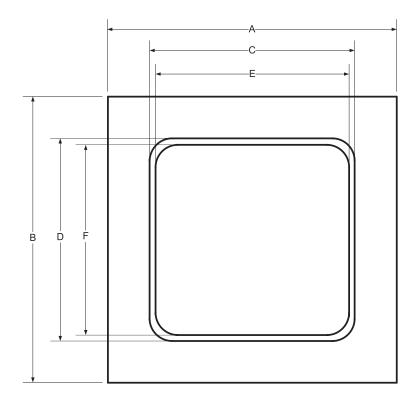
Figure 4: Typical Capacitive Energy vs Reverse Voltage Characteristics



## **Mechanical Parameters**

Die Dimensions	4.5 x 4.5			
Anode Pad Size	4.24 x 4.24	mm <sup>2</sup>		
Die Area total / active	20.25/17.64			
Die Thickness	360	μm		
Wafer Size	100	mm		
Flat Position	0	deg		
Die Frontside Passivation	Polyimide	Polyimide		
Anode Pad Metallization	4000 nm Al	4000 nm Al		
Backside Cathode Metallization	400 nm Ni + 200 nm A	u		
Die Attach	Electrically conductive glue of	Electrically conductive glue or solder		
Wire Bond	Al ≤ 380 μm	Al ≤ 380 μm		
Reject ink dot size	Φ ≥ 0.3 mm	Φ ≥ 0.3 mm		
Deserves de defense en la constante	Store in original container, in dr	Store in original container, in dry nitrogen,		
Recommended storage environment	< 6 months at an ambient tempera	< 6 months at an ambient temperature of 23 °C		

## Chip Dimensions:



DIE	A [mm]	4.5	
	B [mm]	4.5	
METAL	C [mm]	4.24	
	D [mm]	4.24	
WIRE	E [mm]	4.2	
BONDABLE	F [mm]	4.2	



Revision History					
Date	Revision	Comments	Supersedes		
2015/02/12	3	Inserted Mechanical Parameters			
2014/09/12	2	Updated Electrical Characteristics			
2013/11/12	1	Updated Electrical Characteristics			
2013/09/18	0	Initial Release			

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## **SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/hit\_sic/baredie/schottky/GB50SLT12-CAL\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GB50SLT12-CAL.

```
*
     MODEL OF GeneSiC Semiconductor Inc.
*
*
     $Revision: 1.0
                                  $
*
                                  $
     $Date: 20-SEP-2013
*
     GeneSiC Semiconductor Inc.
*
     43670 Trade Center Place Ste. 155
*
     Dulles, VA 20166
     COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY OF ANY
* KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED TO ANY IMPLIED
* WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE."
 Models accurate up to 2 times rated drain current.
 Start of GB50SLT12-CAL SPICE Model
*
.SUBCKT GB50SLT12 ANODE KATHODE
D1 ANODE KATHODE GB50SLT12 SCHOTTKY
D2 ANODE KATHODE GB50SLT12 SURGE
.MODEL GB50SLT12 SCHOTTKY D
           1.99E-16
+ IS
                            RS
                                        0.015652965
+ N
           1
                            IKF
                                        1000
           1.2
+ EG
                                        3
                            XTI
+ TRS1
           0.0042
                            TRS2
                                        1.3E-05
+ CJO
           3.86E-09
                            VJ
                                        1.362328465
           0.48198551
                            FC
                                        0.5
+ M
           1.00E-10
+ TT
                            ΒV
                                        1200
           1.00E-03
                                        1200
+ IBV
                            VPK
+ IAVE
           50
                            TYPE
                                        SiC Schottky
+ MFG
           GeneSiC Semi
.MODEL GB50SLT12 SURGE D
           1.54E-19
+ IS
                            RS
                                        0.1
           -0.004
+ TRS1
                            Ν
                                        3.941
           3.23
                                        19
+ EG
                            IKF
           0
                                        0.5
+ XTI
                            FC
+ TT
           0
                            ΒV
                                        1200
+ IBV
           1.00E-03
                            VPK
                                        1200
           50
+ IAVE
                                        SiC PiN
                            TYPE
.ENDS
* End of GB50SLT12-CAL SPICE Model
```